Search Notes

Appli	catio	n/Contro	ol N	0.

10/815,528 Examiner

John S. Chu

Applicant(s)/Patent under Reexamination

CLARK ET AL.

Art Unit

1752

	SEARCHED				
Class	Subclass	Date	Examiner		
430	510	3(2007	ysc.		
430	512	1	1		
430	326		/		
430	314				
430	323				
430	324				
438	636	d	4		
,					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
			-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST UPDATED	3/2007	JEC		